

PCA9546A

4-channel I²C switch with reset

Rev. 03 — 6 April 2005

Product data sheet



The PCA9546A is a quad bi-directional translating switch controlled via the I²C-bus. The SCL/SDA upstream pair fans out to four downstream pairs, or channels. Any individual SCx/SDx channel or combination of channels can be selected, determined by the contents of the programmable control register.

An active LOW reset input allows the PCA9546A to recover from a situation where one of the downstream I^2C -buses is stuck in a LOW state. Pulling the \overline{RESET} pin LOW resets the I^2C -bus state machine and causes all the channels to be deselected as does the internal Power-On Reset (POR) function.

The pass gates of the switches are constructed such that the V_{DD} pin can be used to limit the maximum high voltage which will be passed by the PCA9546A. This allows the use of different bus voltages on each pair, so that 1.8 V or 2.5 V or 3.3 V parts can communicate with 5 V parts without any additional protection. External pull-up resistors pull the bus up to the desired voltage level for each channel. All I/O pins are 5 V tolerant.

2. Features

- 1-of-4 bi-directional translating switches
- I²C-bus interface logic; compatible with SMBus standards
- Active LOW reset input
- 3 address pins allowing up to 8 devices on the I²C-bus
- Channel selection via I²C-bus, in any combination
- Power-up with all switch channels deselected
- Low Ron switches
- Allows voltage level translation between 1.8 V, 2.5 V, 3.3 V and 5 V buses
- No glitch on power-up
- Supports hot insertion
- Low stand-by current
- Operating power supply voltage range of 2.3 V to 5.5 V
- 5 V tolerant Inputs
- 0 kHz to 400 kHz clock frequency
- ESD protection exceeds 2000 V HBM per JESD22-A114, 200 V MM per JESD22-A115, and 1000 V CDM per JESD22-C101
- Latch-up testing is done to JEDEC Standard JESD78 which exceeds 100 mA
- Three packages offered: SO16, TSSOP16, and HVQFN16



3. Ordering information

Table 1: Ordering information

 $T_{amb} = -40 \,^{\circ}C$ to +85 $^{\circ}C$

Type number	Package	Package									
	Name	Description	Version								
PCA9546ABS	HVQFN16	plastic thermal enhanced very thin quad flat package; no leads; 16 terminals; body $4\times4\times0.85$ mm	SOT629-1								
PCA9546AD	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1								
PCA9546APW	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1								

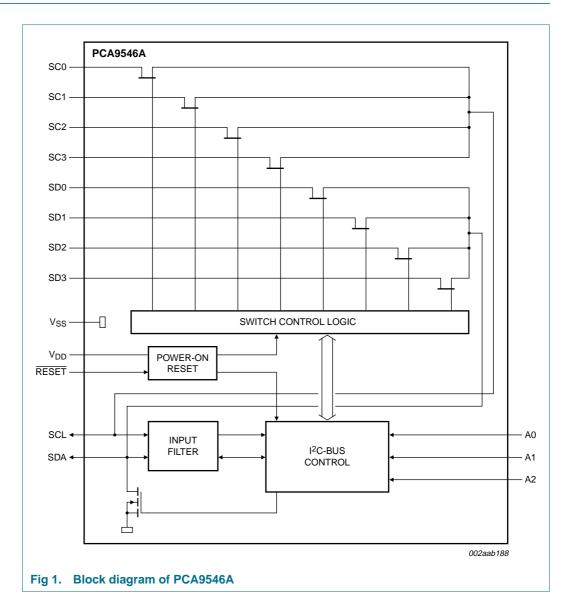
Standard packing quantities and other packaging data are available at www.standardics.philips.com/packaging.

4. Marking

Table 2: Marking codes

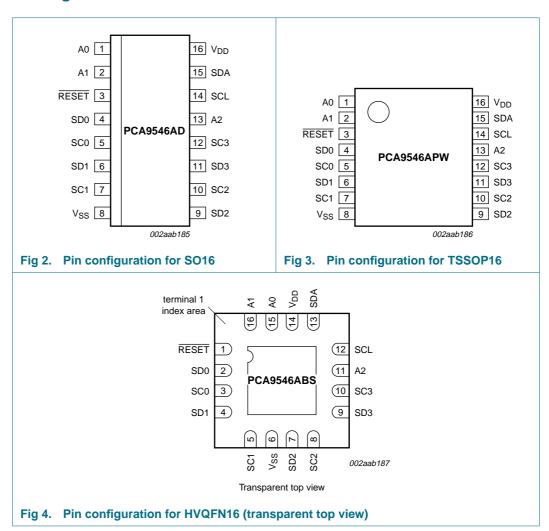
Type number	Topside mark
PCA9546ABS	546A
PCA9546AD	PCA9546AD
PCA9546APW	PA9546A

5. Block diagram



6. Pinning information

6.1 Pinning



6.2 Pin description

Table 3: Pin description

Symbol	Pin		Description
	SO, TSSOP	HVQFN	
A0	1	15	address input 0
A1	2	16	address input 1
RESET	3	1	active LOW reset input
SD0	4	2	serial data 0
SC0	5	3	serial clock 0
SD1	6	4	serial data 1
SC1	7	5	serial clock 1
V _{SS}	8	6 <u>[1]</u>	supply ground
SD2	9	7	serial data 2
SC2	10	8	serial clock 2
SD3	11	9	serial data 3
SC3	12	10	serial clock 3
A2	13	11	address input 2
SCL	14	12	serial clock line
SDA	15	13	serial data line
V_{DD}	16	14	supply voltage

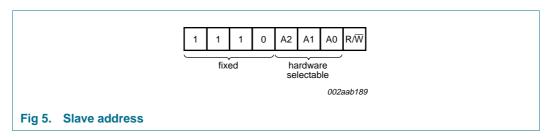
^[1] HVQFN package die supply ground is connected to both the V_{SS} pin and the exposed center pad. The V_{SS} pin must be connected to supply ground for proper device operation. For enhanced thermal, electrical, and board-level performance, the exposed pad needs to be soldered to the board using a corresponding thermal pad on the board, and for proper heat conduction through the board thermal vias need to be incorporated in the PCB in the thermal pad region.

7. Functional description

Refer to Figure 1 "Block diagram of PCA9546A" on page 3.

7.1 Device address

Following a START condition, the bus master must output the address of the slave it is accessing. The address of the PCA9546A is shown in Figure 5. To conserve power, no internal pull-up resistors are incorporated on the hardware selectable address pins and they must be pulled HIGH or LOW.



The last bit of the slave address defines the operation to be performed. When set to logic 1 a read is selected, while a logic 0 selects a write operation.

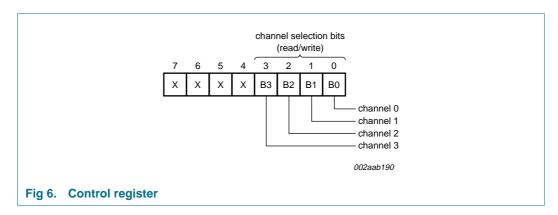
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4-channel I2C switch with reset

7.2 Control register

Following the successful acknowledgement of the slave address, the bus master will send a byte to the PCA9546A, which will be stored in the control register. If multiple bytes are received by the PCA9546A, it will save the last byte received. This register can be written and read via the I²C-bus.



7.2.1 Control register definition

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One or several SCx/SDx downstream pair, or channel, is selected by the contents of the control register. This register is written after the PCA9546A has been addressed. The 4 LSBs of the control byte are used to determine which channel is to be selected. When a channel is selected, the channel will become active after a STOP condition has been placed on the I²C-bus. This ensures that all SCx/SDx lines will be in a HIGH state when the channel is made active, so that no false conditions are generated at the time of connection.

D7	D6	D5	D4	В3	B2	B1	В0	Command
X	Х	X	Х	Х	Х	X	0	channel 0 disabled
^	^	^	^	^	^	^	1	channel 0 enabled
V	Χ	Χ	Х	Х	Х	0	X	channel 1 disabled
^	^	^	^	^	^	1		channel 1 enabled
V	Х	Х	Х	Х	0	V	Х	channel 2 disabled
^	^	^	^	^	1		^	channel 2 enabled
V	Х	X	V	0	X	V	X	channel 3 disabled
^	^	^	^	1		^	^	channel 3 enabled

Table 4: Control register: Write—channel selection; Read—channel status

Remark: Several channels can be enabled at the same time. Example: B3 = 0, B2 = 1, B1 = 1, B0 = 0, means that channel 0 and channel 3 are disabled and channel 1 and channel 2 are enabled. Care should be taken not to exceed the maximum bus capacitance.

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no channel selected; power-up/reset default state

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7.3 RESET input

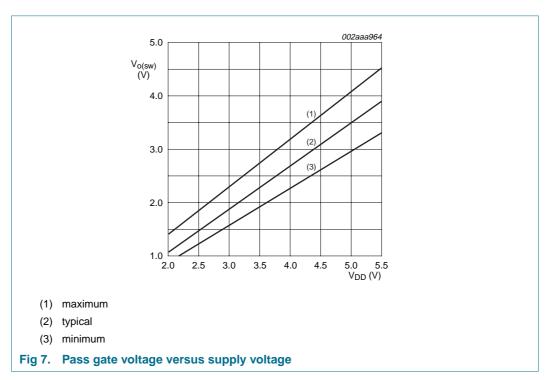
The $\overline{\text{RESET}}$ input is an active LOW signal which may be used to recover from a bus fault condition. By asserting this signal LOW for a minimum of t_{WL} , the PCA9546A will reset its registers and I²C-bus state machine and will deselect all channels. The $\overline{\text{RESET}}$ input must be connected to V_{DD} through a pull-up resistor.

7.4 Power-on reset

When power is applied to V_{DD} , an internal Power-On Reset (POR) holds the PCA9546A in a reset condition until V_{DD} has reached V_{POR} . At this point, the reset condition is released and the PCA9546A registers and I²C-bus state machine are initialized to their default states—all zeroes—causing all the channels to be deselected. Thereafter, V_{DD} must be lowered below 0.2 V to reset the device.

7.5 Voltage translation

The pass gate transistors of the PCA9546A are constructed such that the V_{DD} voltage can be used to limit the maximum voltage that will be passed from one I^2C -bus to another.



<u>Figure 7</u> shows the voltage characteristics of the pass gate transistors (note that the graph was generated using the data specified in <u>Section 11 "Static characteristics"</u> of this data sheet). In order for the PCA9546A to act as a voltage translator, the $V_{o(sw)}$ voltage should be equal to, or lower than the lowest bus voltage. For example, if the main bus was running at 5 V, and the downstream buses were 3.3 V and 2.7 V, then $V_{o(sw)}$ should be equal to or below 2.7 V to effectively clamp the downstream bus voltages. Looking at <u>Figure 7</u>, we see that $V_{o(sw)(max)}$ will be at 2.7 V when the PCA9546A supply voltage is 3.5 V or lower, so the PCA9546A supply voltage could be set to 3.3 V. Pull-up resistors can then be used to bring the bus voltages to their appropriate levels (see <u>Figure 14</u>).

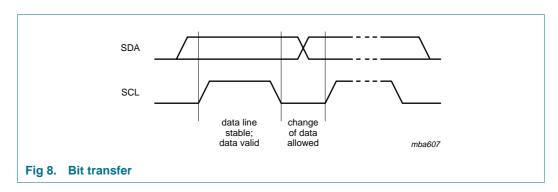
More Information can be found in Application Note *AN262: PCA954X family of I2C/SMBus multiplexers and switches*.

8. Characteristics of the I²C-bus

The I²C-bus is for 2-way, 2-line communication between different ICs or modules. The two lines are a serial data line (SDA) and a serial clock line (SCL). Both lines must be connected to a positive supply via a pull-up resistor when connected to the output stages of a device. Data transfer may be initiated only when the bus is not busy.

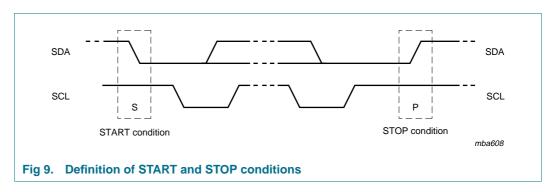
8.1 Bit transfer

One data bit is transferred during each clock pulse. The data on the SDA line must remain stable during the HIGH period of the clock pulse as changes in the data line at this time will be interpreted as control signals (see Figure 8).



8.2 START and STOP conditions

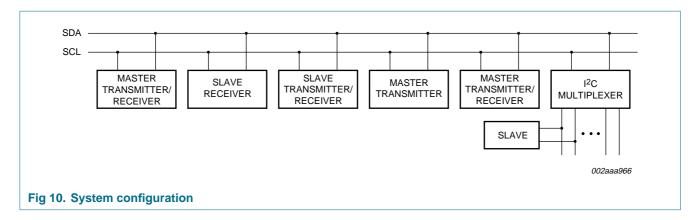
Both data and clock lines remain HIGH when the bus is not busy. A HIGH-to-LOW transition of the data line while the clock is HIGH is defined as the START condition (S). A LOW-to-HIGH transition of the data line while the clock is HIGH is defined as the STOP condition (P) (see Figure 9).



8.3 System configuration

A device generating a message is a 'transmitter', a device receiving is the 'receiver'. The device that controls the message is the 'master' and the devices which are controlled by the master are the 'slaves' (see Figure 10).

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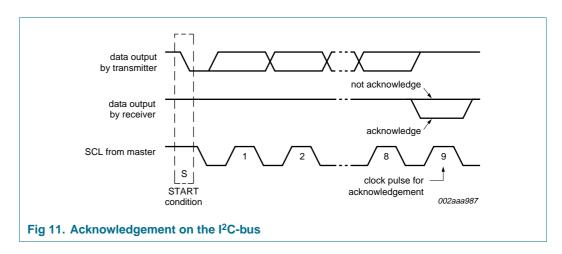


8.4 Acknowledge

The number of data bytes transferred between the START and the STOP conditions from transmitter to receiver is not limited. Each byte of eight bits is followed by one acknowledge bit. The acknowledge bit is a HIGH level put on the bus by the transmitter, whereas the master generates an extra acknowledge related clock pulse.

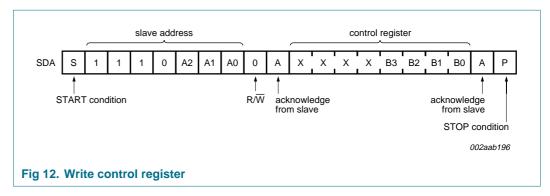
A slave receiver which is addressed must generate an acknowledge after the reception of each byte. Also, a master must generate an acknowledge after the reception of each byte that has been clocked out of the slave transmitter. The device that acknowledges has to pull down the SDA line during the acknowledge clock pulse so that the SDA line is stable LOW during the HIGH period of the acknowledge related clock pulse; setup and hold times must be taken into account.

A master receiver must signal an end of data to the transmitter by not generating an acknowledge on the last byte that has been clocked out of the slave. In this event, the transmitter must leave the data line HIGH to enable the master to generate a STOP condition.

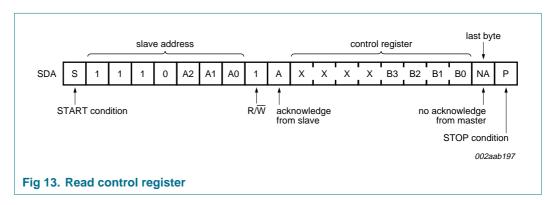


8.5 Bus transactions

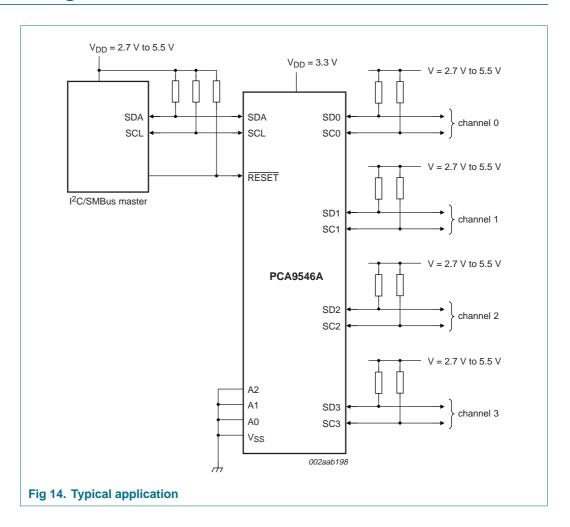
Data is transmitted to the PCA9546A control register using the Write mode as shown in Figure 12.



Data is read from PCA9546A using the Read mode as shown in Figure 13.



9. Application design-in information



10. Limiting values

Table 5: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to V_{SS} (ground = 0 V). [1]

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DD}	supply voltage		-0.5	+7.0	V
VI	input voltage		-0.5	+7.0	V
I _I	input current		-	±20	mA
I _O	output current		-	±25	mA
I_{DD}	supply current		-	±100	mA
I _{SS}	ground supply current		-	±100	mA
P_{tot}	total power dissipation		-	400	mW
T _{stg}	storage temperature		-60	+150	°C
T_{amb}	operating ambient temperature		-40	+85	°C

^[1] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

11. Static characteristics

DC characteristics Table 6:

 V_{DD} = 2.3 V to 3.6 V; V_{SS} = 0 V; T_{amb} = -40 °C to +85 °C; unless otherwise specified. See <u>Table 7 on page 14</u> for V_{DD} = 4.5 V to 5.5 V.[1]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Supply						
V_{DD}	supply voltage		2.3	-	3.6	V
I _{DD}	supply current	Operating mode; $V_{DD} = 3.6 \text{ V}$; no load; $V_{I} = V_{DD}$ or V_{SS} ; $f_{SCL} = 100 \text{ kHz}$	-	16	50	μΑ
I _{stb}	standby current	Standby mode; $V_{DD} = 3.6 \text{ V}$; no load; $V_{I} = V_{DD}$ or V_{SS}	-	0.1	1	μΑ
V_{POR}	power-on reset voltage	no load; $V_I = V_{DD}$ or V_{SS}	[2] _	1.6	2.1	V
Input SCI	_; input/output SDA					
V_{IL}	LOW-level input voltage		-0.5	-	$0.3V_{DD}$	V
V _{IH}	HIGH-level input voltage		$0.7V_{DD}$	-	6	V
I _{OL}	LOW-level output current	V _{OL} = 0.4 V	3	-	-	mΑ
		V _{OL} = 0.6 V	6	-	-	mΑ
IL	leakage current	$V_I = V_{DD}$ or V_{SS}	-1	-	+1	μΑ
C _i	input capacitance	$V_I = V_{SS}$	-	12	13	pF
Select in	outs A0 to A2, RESET					
V _{IL}	LOW-level input voltage		-0.5	-	$0.3V_{DD}$	V
V _{IH}	HIGH-level input voltage		$0.7V_{DD}$	-	$V_{DD} + 0.5$	V
ILI	input leakage current	pin at V _{DD} or V _{SS}	-1	-	+1	μΑ
Ci	input capacitance	$V_I = V_{SS}$	-	1.6	3	pF
Pass gate	9					
R _{on}	on-state resistance	$V_{DD} = 3.67 \text{ V}; V_{O} = 0.4 \text{ V}; I_{O} = 15 \text{ mA}$	5	11	30	Ω
		V_{DD} = 2.3 V to 2.7 V; V_{O} = 0.4 V; I_{O} = 10 mA	7	16	55	Ω
$V_{o(sw)}$	switch output voltage	$V_{i(sw)} = V_{DD} = 3.3 \text{ V; } I_{o(sw)} = -100 \mu\text{A}$	-	1.9	-	V
		$V_{i(sw)} = V_{DD} = 3.0 \text{ V to } 3.6 \text{ V};$ $I_{o(sw)} = -100 \mu\text{A}$	1.6	-	2.8	V
		$V_{i(sw)} = V_{DD} = 2.5 \text{ V}; I_{o(sw)} = -100 \mu\text{A}$	-	1.5	-	V
		$V_{i(sw)} = V_{DD} = 2.3 \text{ V to } 2.7 \text{ V};$ $I_{o(sw)} = -100 \mu\text{A}$	1.1	-	2.0	V
IL	leakage current	$V_I = V_{DD}$ or V_{SS}	-1	-	+1	μΑ
C _{io}	input/output capacitance	$V_I = V_{SS}$	-	3	5	pF

^[1] For operation between published voltage ranges, refer to the worst-case parameter in both ranges.

^[2] V_{DD} must be lowered to 0.2 V in order to reset part.

Table 7: DC characteristics

 V_{DD} = 4.5 V to 5.5 V; V_{SS} = 0 V; T_{amb} = -40 °C to +85 °C; unless otherwise specified. See <u>Table 6 on page 13</u> for V_{DD} = 2.3 V to 3.6 V.[1]

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Supply							
V_{DD}	supply voltage			4.5	-	5.5	V
I _{DD}	supply current	Operating mode; $V_{DD} = 5.5 \text{ V}$; no load; $V_{I} = V_{DD}$ or V_{SS} ; $f_{SCL} = 100 \text{ kHz}$		-	65	100	μΑ
I _{stb}	standby current	Standby mode; $V_{DD} = 5.5 \text{ V}$; no load; $V_{I} = V_{DD}$ or V_{SS}		-	0.3	1	μΑ
V _{POR}	power-on reset voltage	no load; $V_I = V_{DD}$ or V_{SS}	[2]	-	1.7	2.1	V
Input SCL	.; input/output SDA						
V _{IL}	LOW-level input voltage			-0.5	-	$0.3V_{DD}$	V
V _{IH}	HIGH-level input voltage			$0.7V_{DD}$	-	6	V
I _{OL}	LOW-level output current	V _{OL} = 0.4 V		3	-	-	mΑ
		V _{OL} = 0.6 V		6	-	-	mA
I _{IL}	LOW-level input current	$V_I = V_{SS}$		1	-	1	μΑ
I _{IH}	HIGH-level input current	$V_I = V_{DD}$		1	-	1	μΑ
C _i	input capacitance	$V_I = V_{SS}$		-	12	13	pF
Select inp	outs A0 to A2, RESET						
V _{IL}	LOW-level input voltage			-0.5	-	$0.3V_{DD}$	V
V _{IH}	HIGH-level input voltage			$0.7V_{DD}$	-	$V_{DD} + 0.5$	V
I _{LI}	input leakage current	pin at V _{DD} or V _{SS}		-1	-	+1	μΑ
C _i	input capacitance	$V_I = V_{SS}$		-	2	3	pF
Pass gate)						
R _{on}	on-state resistance	V_{DD} = 4.5 V to 5.5 V; V_{O} = 0.4 V; I_{O} = 15 mA		4	9	24	Ω
$V_{o(sw)}$	switch output voltage	$V_{i(sw)} = V_{DD} = 5.0 \text{ V};$ $I_{o(sw)} = -100 \mu\text{A}$		-	3.6	-	V
		$\begin{split} V_{i(sw)} &= V_{DD} = 4.5 \text{ V to 5.5 V;} \\ I_{o(sw)} &= -100 \mu\text{A} \end{split}$		2.6	-	4.5	V
IL	leakage current	$V_I = V_{DD}$ or V_{SS}		-1	-	+1	μΑ
C _{io}	input/output capacitance	$V_I = V_{SS}$		-	3	5	pF

^[1] For operation between published voltage ranges, refer to the worst-case parameter in both ranges.

^[2] V_{DD} must be lowered to 0.2 V in order to reset part.

12. Dynamic characteristics

Table 8: Dynamic characteristics

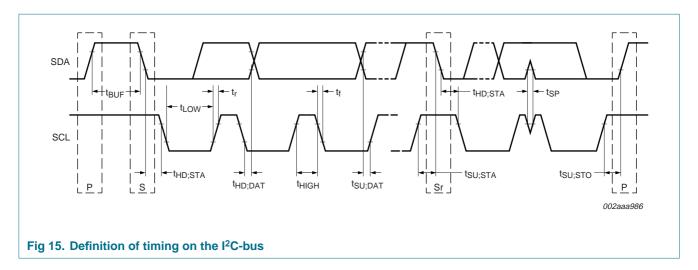
Symbol	Parameter	Conditions		Standar I ² C-		Fast-mode	l ² C-bus	Unit
				Min	Max	Min	Max	
t _{PD}	propagation delay from SDA to SDn, or SCL to SCn			-	0.3[1]	-	0.3[1]	ns
f _{SCL}	SCL clock frequency			0	100	0	400	kHz
t _{BUF}	bus free time between a STOP and START condition			4.7	-	1.3	-	μs
t _{HD;STA}	hold time (repeated) START condition. After this period, the first clock pulse is generated.			4.0	-	0.6	-	μs
t_{LOW}	LOW period of the SCL clock			4.7	-	1.3	-	μs
t _{HIGH}	HIGH period of the SCL clock			4.0	-	0.6	-	μs
t _{SU;STA}	setup time for a repeated START condition			4.7	-	0.6	-	μs
t _{SU;STO}	setup time for STOP condition			4.0	-	0.6	-	μs
t _{HD;DAT}	data hold time			0[2]	3.45	0[2]	0.9	μs
t _{SU;DAT}	data setup time			250	-	100	-	ns
t _r	rise time of both SDA and SCL signals			-	1000	$20 + 0.1C_b$ [3]	300	ns
t _f	fall time of both SDA and SCL signals			-	300	$20 + 0.1C_b$ [3]	300	μs
C _b	capacitive load for each bus line			-	400	-	400	μs
t _{SP}	pulse width of spikes which must be suppressed by the input filter			-	50	-	50	ns
t _{VD;DAT}	data valid time	HIGH-to-LOW	<u>[4]</u>	-	1	-	1	μs
		LOW-to-HIGH	<u>[4]</u>	-	0.6	-	0.6	μs
t _{VD;ACK}	data valid Acknowledge			-	1	-	1	μs
RESET								
t _{w(rst)L}	LOW-level reset time			4	-	4	-	ns
t _{rst}	reset time (SDA clear)			500	-	500	-	ns
t _{REC;STA}	recovery time to START condition			0	-	0	-	ns

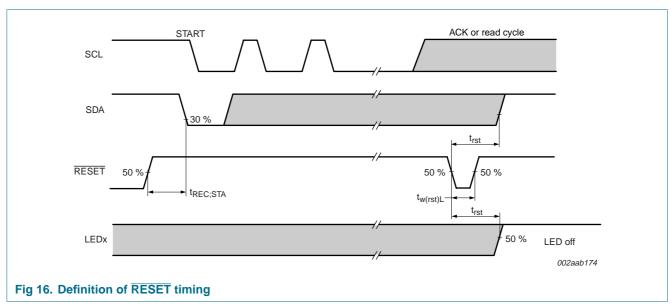
^[1] Pass gate propagation delay is calculated from the 20 Ω typical R_{on} and the 15 pF load capacitance.

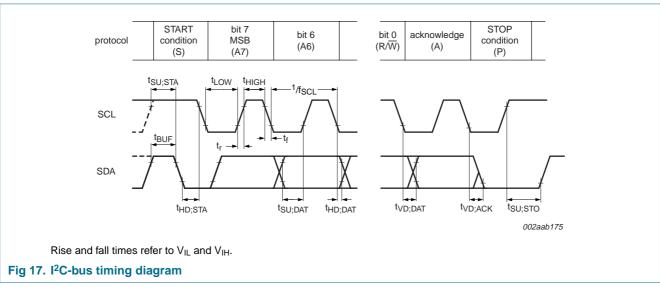
^[2] A device must internally provide a hold time of at least 300 ns for the SDA signal (referred to the V_{IH(min)} of the SCL signal) in order to bridge the undefined region of the falling edge of SCL.

^[3] $C_b = total$ capacitance of one bus line in pF.

^[4] Measurements taken with 1 $k\Omega$ pull-up resistor and 50 pF load.







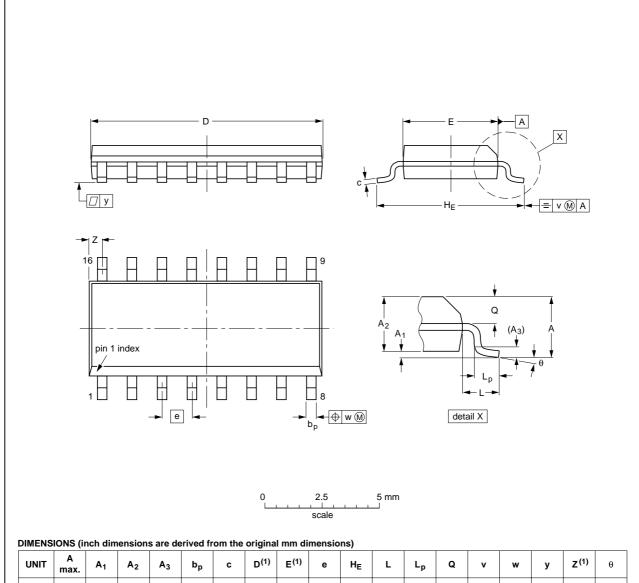
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13. Package outline

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	10.0 9.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.39 0.38	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.020	0.01	0.01	0.004	0.028 0.012	0°

Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

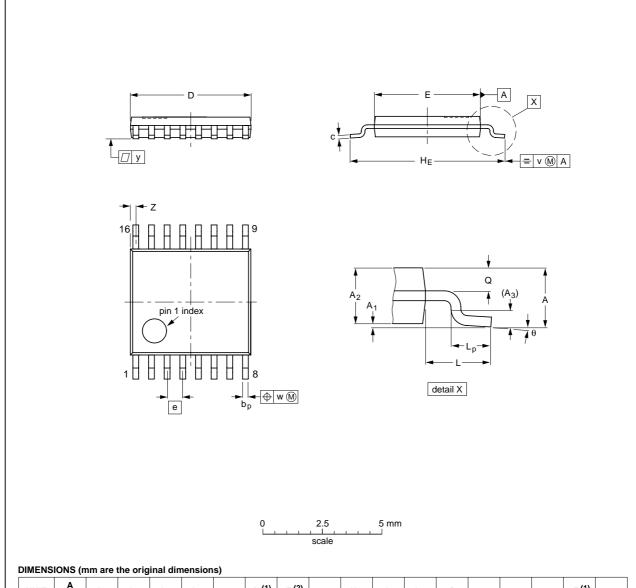
OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT109-1	076E07	MS-012			99-12-27 03-02-19

Fig 18. Package outline SOT109-1 (SO16)

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TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1



				,		-,												
UNIT	A max.	A ₁	A ₂	А3	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.40 0.06	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	ENCES		EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT403-1		MO-153				99-12-27 03-02-18
	•	•	•	•		•

Fig 19. Package outline SOT403-1 (TSSOP16)

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HVQFN16: plastic thermal enhanced very thin quad flat package; no leads; 16 terminals; body 4 x 4 x 0.85 mm

SOT629-1

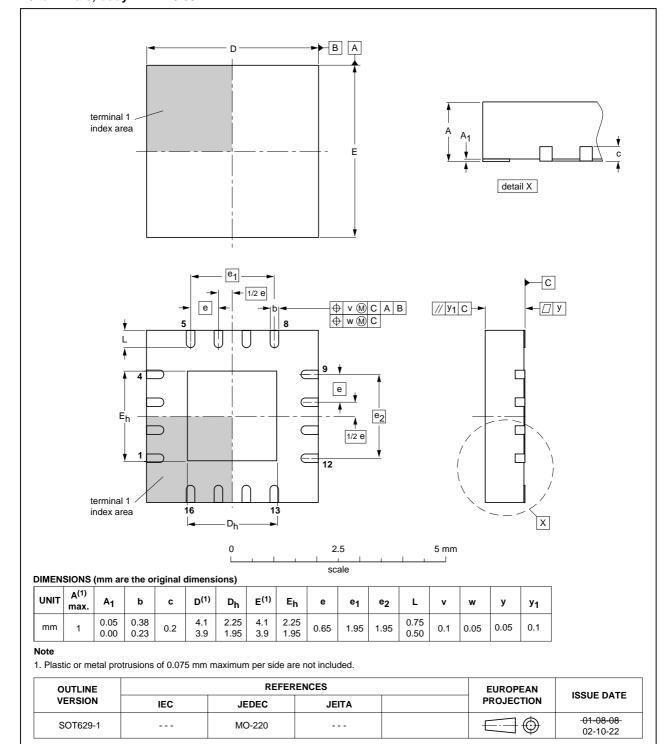


Fig 20. Package outline SOT629-1 (HVQFN16)

4-channel I2C switch with reset



14.1 Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *Data Handbook IC26; Integrated Circuit Packages* (document order number 9398 652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

14.2 Reflow soldering

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement. Driven by legislation and environmental forces the worldwide use of lead-free solder pastes is increasing.

Several methods exist for reflowing; for example, convection or convection/infrared heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 seconds and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 °C to 270 °C depending on solder paste material. The top-surface temperature of the packages should preferably be kept:

- below 225 °C (SnPb process) or below 245 °C (Pb-free process)
 - for all BGA, HTSSON..T and SSOP..T packages
 - for packages with a thickness ≥ 2.5 mm
 - for packages with a thickness < 2.5 mm and a volume ≥ 350 mm³ so called thick/large packages.
- below 240 °C (SnPb process) or below 260 °C (Pb-free process) for packages with a thickness < 2.5 mm and a volume < 350 mm³ so called small/thin packages.

Moisture sensitivity precautions, as indicated on packing, must be respected at all times.

14.3 Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
 - larger than or equal to 1.27 mm, the footprint longitudinal axis is preferred to be parallel to the transport direction of the printed-circuit board;

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 smaller than 1.27 mm, the footprint longitudinal axis must be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

• For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time of the leads in the wave ranges from 3 seconds to 4 seconds at 250 °C or 265 °C, depending on solder material applied, SnPb or Pb-free respectively.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

14.4 Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to $300\,^{\circ}$ C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 seconds to 5 seconds between 270 °C and 320 °C.

14.5 Package related soldering information

Table 9: Suitability of surface mount IC packages for wave and reflow soldering methods

Package [1]	Soldering method		
	Wave	Reflow [2]	
BGA, HTSSONT 3, LBGA, LFBGA, SQFP, SSOPT 3, TFBGA, VFBGA, XSON	not suitable	suitable	
DHVQFN, HBCC, HBGA, HLQFP, HSO, HSOP, HSQFP, HSSON, HTQFP, HTSSOP, HVQFN, HVSON, SMS	not suitable [4]	suitable	
PLCC 5, SO, SOJ	suitable	suitable	
LQFP, QFP, TQFP	not recommended [5] [6]	suitable	
SSOP, TSSOP, VSO, VSSOP	not recommended [7]	suitable	
CWQCCNL [8], PMFP [9], WQCCNL [8]	not suitable	not suitable	

^[1] For more detailed information on the BGA packages refer to the (*LF*)BGA Application Note (AN01026); order a copy from your Philips Semiconductors sales office.

- [2] All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods.
- [3] These transparent plastic packages are extremely sensitive to reflow soldering conditions and must on no account be processed through more than one soldering cycle or subjected to infrared reflow soldering with peak temperature exceeding 217 °C ± 10 °C measured in the atmosphere of the reflow oven. The package body peak temperature must be kept as low as possible.

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4-channel I²C switch with reset

- [4] These packages are not suitable for wave soldering. On versions with the heatsink on the bottom side, the solder cannot penetrate between the printed-circuit board and the heatsink. On versions with the heatsink on the top side, the solder might be deposited on the heatsink surface.
- [5] If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
- [6] Wave soldering is suitable for LQFP, QFP and TQFP packages with a pitch (e) larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.
- [7] Wave soldering is suitable for SSOP, TSSOP, VSO and VSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.
- [8] Image sensor packages in principle should not be soldered. They are mounted in sockets or delivered pre-mounted on flex foil. However, the image sensor package can be mounted by the client on a flex foil by using a hot bar soldering process. The appropriate soldering profile can be provided on request.
- [9] Hot bar soldering or manual soldering is suitable for PMFP packages.

15. Abbreviations

Table 10: Abbreviations

Acronym	Description			
CDM	Charged Device Model			
ESD	Electro Static Discharge			
HBM	Human Body Model			
IC	Integrated Circuit			
LSB	Least Significant Bit			
MM	Machine Model			
MSB	Most Significant Bit			
PCB	Printed-Circuit Board			

16. Revision history

Table 11: Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
PCA9546A_3	20050406	Product data sheet	-	9397 750 14318	PCA9546A_2

Modifications:

- The format of this data sheet has been redesigned to comply with the new presentation and information standard of Philips Semiconductors.
- Section 2 "Features" on page 1:
 - 7th bullet: changed 'RDS_{ON}' to 'Ron'
 - 16th bullet: changed 'JESDEC' to 'JEDEC'
- Figure 4 "Pin configuration for HVQFN16 (transparent top view)" on page 4:
 - added pin 1 indicator notch and center pad
 - changed pin 1 from 'A2' to 'RESET'
- Section 6.2 "Pin description" on page 5: added Table note 1 and its reference at HVQFN pin 6.
- Section 7.2.1 "Control register definition" on page 6, third sentence: changed 'The 2 LSBs of the
 control byte ...' to 'The 4 LSBs of the control byte ...'
- Section 7.5 "Voltage translation" on page 7:
 - Figure 7 modified and title changed from 'V_{pass} voltage versus V_{DD}' to 'Pass gate voltage versus supply voltage'
 - 2nd paragraph: changed symbol 'V_{pass}' and 'V_{pass(max)}' to 'V_{o(sw)}' and 'V_{o(sw)(max)}', respectively.

Table 11: Revis	ion historycontinued						
Document ID	Release date Data sheet status Change notice Doc. number Supersedes						
Modifications (continued):	 Added Section 8.5 "Bus transactions" on page 10; moved Figure 12 "Write control register" and Figure 13 "Read control register" to this section. 						
	• Table 5 "Limiting values" on page 12:						
	 In the description line below table title, changed 'referenced to GND' to 'referenced to V_{SS}' 						
	 Removed (old) table note [1], as this statement is now covered in <u>Section 19 "Disclaimers"</u> 						
	• Table 6 "DC characteristics" on page 13:						
	 added (new) Table note 1 changed symbol 'R_{ON}' to 'R_{on}' and its parameter from 'switch resistance' to 'on-state resistance' changed symbol 'V_{pass}' to 'V_{o(sw)}' under Conditions column: changed 'V_{swin}' to 'V_{i(sw)}'; changed 'I_{swout}' to I_{o(sw)}' 						
	• Table 7 "DC characteristics" on page 14:						
	- added (new) Table note 1						
	 sub-section 'Select inputs A0 to A2, RESET': changed I_{LI(max)} from '+50 μA' to '+1 μA'. 						
	 sub-section 'Pass gate': changed I_{L(min)} from '-10 μA' to '-1 μA'; changed I_{L(max)} from '+100 μA' to '+1 μA' 						
	 changed symbol 'R_{ON}' to 'R_{on}' and its parameter from 'switch resistance' to 'on-state resistance' 						
	 changed symbol 'V_{pass}' to 'V_{o(sw)}' 						
	 under Conditions column: changed 'V_{swin}' to 'V_{i(sw)}'; changed 'I_{swout}' to I_{o(sw)}' 						
	• Table 8 "Dynamic characteristics" on page 15:						
	 symbol 't_R' changed to 't_r'; symbol 't_F' changed to 't_f' 						
	 changed symbols 't_{VD;DATL}' and 't_{VD;DATH}' to 't_{VD;DAT}' and added Conditions indicating HIGH-to-LOW and LOW-to-HIGH transitions 						
	 changed symbol 't_{WL(rst)}' to 't_{w(rst)L}' 						
	 changed parameter for symbol t_{REC;STA} from 'recovery to START' to 'recovery time to START condition' 						
	 in <u>Table note 1</u>: changed 'R_{ON}' to 'R_{on}' 						
	 Added <u>Figure 16</u> and <u>Figure 17</u> 						
	Added <u>Section 15 "Abbreviations"</u>						

				
PCA9546A_2	20040929	Objective data sheet	-	9397 750 13991 PCA9546A_1
PCA9546A 1	20040728	Objective data sheet	_	9397 750 13308 -

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Level	Data sheet status [1]	Product status [2] [3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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- [3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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